Ī	Application/Control No.	Applicant(s)/Pater	nt Under	
10/660,535		Reexamination OHISHI ET AL.		
	Examiner	Art Unit		
	Dov Popovici	2625	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,069,706	05-2000	Kajita et al.	358/1.15
*	В	US-2003/0140174	07-2003	Ohishi et al.	709/310
*	υ	US-2003/0218765	11-2003	Ohishi et al.	358/1.13
*	D	US-2004/0021890	02-2004	Hirai et al.	358/1.13
*	Е	US-2004/0057074	03-2004	Ohishi et al.	358/001.15
*	F	US-2004/0057067	03-2004	Ohishi et al.	358/001.13
*	G	US-2004/0075857	04-2004	Akiyoshi et al.	358/001.13
*	н	US-2004/0218208	11-2004	Akiyoshi et al.	358/001.15
*	-	US-7,280,238	10-2007	Akiyoshi, Kunihiro	358/1.14
*	7	US-2003/0072023	04-2003	Tanaka, Hiroyuki	358/1.13
*	К	US-2003/0133136	07-2003	Ohishi et al.	358/1.1
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	Т					

NON-PATENT DOCUMENTS

*	NON-FAIENT DOCUMENTS			
_		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	w			
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